



### **RAMDENT: THERMAL RUNAWAY INITIATION METHOD**

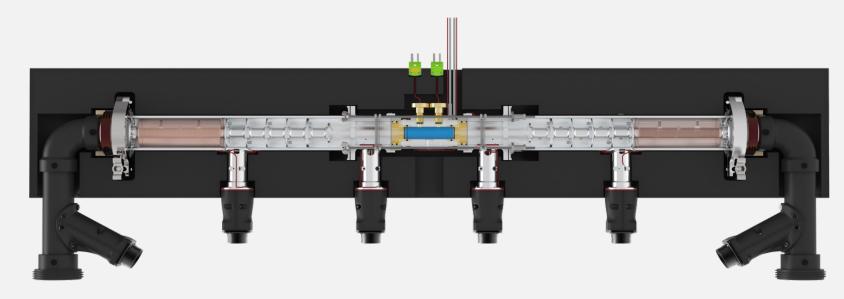
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## Background



- Developed a calorimeter tailored specifically for measuring thermal runaway-induced energy output
- Able to discern
   between the fraction
   of heat conducted
   through can versus
   ejected heat



Fractional Thermal Runaway Calorimeter (FTRC)



## Background



- Type of trigger method employed significantly influences the cell's response during thermal runaway
- Influence extends to both thermal and kinetic energy outputs





## Background



Circumferential Heater

- Utilizes three primary techniques to initiate thermal runaway in batteries.
  - Nail penetration
  - Heaters
  - Internal Short Circuit Device (ISCD)
- Methods have shown reasonable consistency and success in causing cell failure, but they come with certain drawbacks





### Trigger Mechanism: Heaters

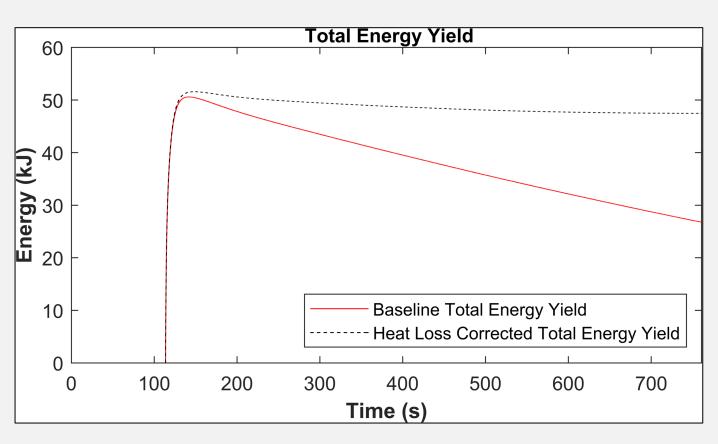


### Benefits

- Reliable
- Non-intrusive trigger method

#### **Drawbacks**

- Poor Signal-to-Noise Ratio
- Causes Time Delay between Venting and TR



Moli M35A 100% SOC ~ Energy Yield Algorithm (EYAN) Output



### Trigger Mechanism: Nail Penetration

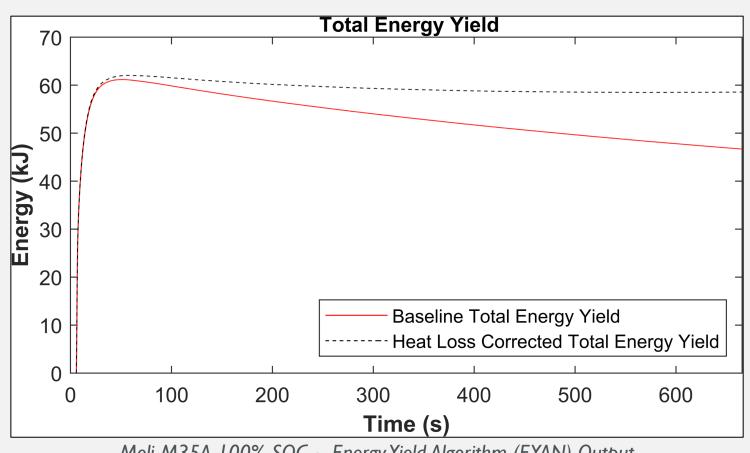


### **Benefits**

- Time effective trigger method
- No Heat Input

#### **Drawbacks**

- Additional Thermal Conduction Path
- Can Wall Perforation
- Impedes Jelly Roll Ejection



Moli M35A 100% SOC ~ Energy Yield Algorithm (EYAN) Output

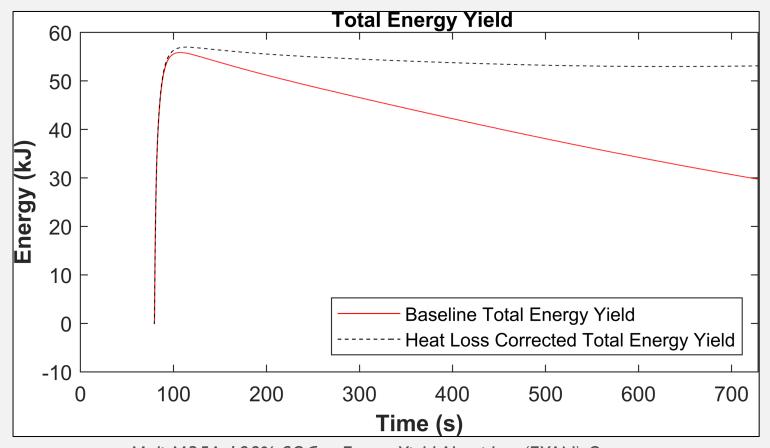
# rigger Mechanism : Internal Short Circuit Device

### Benefits

- Control over location of the internal short
- Low energy input

#### **Drawbacks**

- Requires willing manufacturer to do implantation
- Expensive to use for testing



Moli M35A 100% SOC ~ Energy Yield Algorithm (EYAN) Output



# Trigger Mechanism Comparison



	Heater	Nail Penetration	ISCD
Time Effective		<b>~</b>	
Non-Intrusive	<b>~</b>		
Reliable	<b>~</b>		<b>~</b>
Cost Effective	<b>~</b>	<b>~</b>	
Minimal Energy Input		<b>~</b>	<b>~</b>
Signal-Noise Ratio		<b>~</b>	
Represents a  Defect Induced  Failure			<b>~</b>

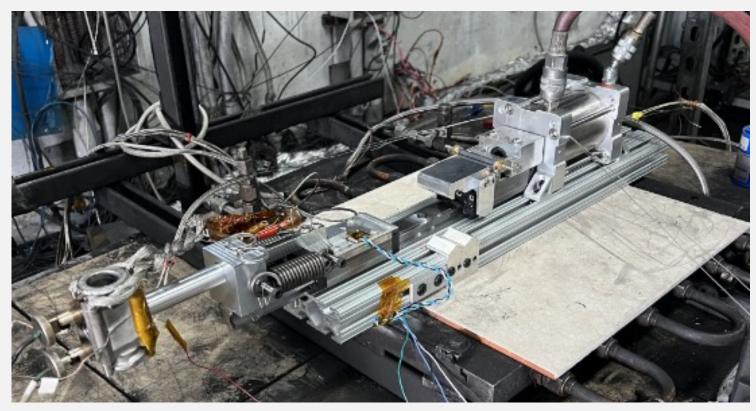


### Trigger Method: RamDent



#### Mechanism Overview

- Utilizes a ramming component to accelerate a probe
- 2) Accelerated probe impacts the battery cell
- 3) Results in subtle deformation of the can wall

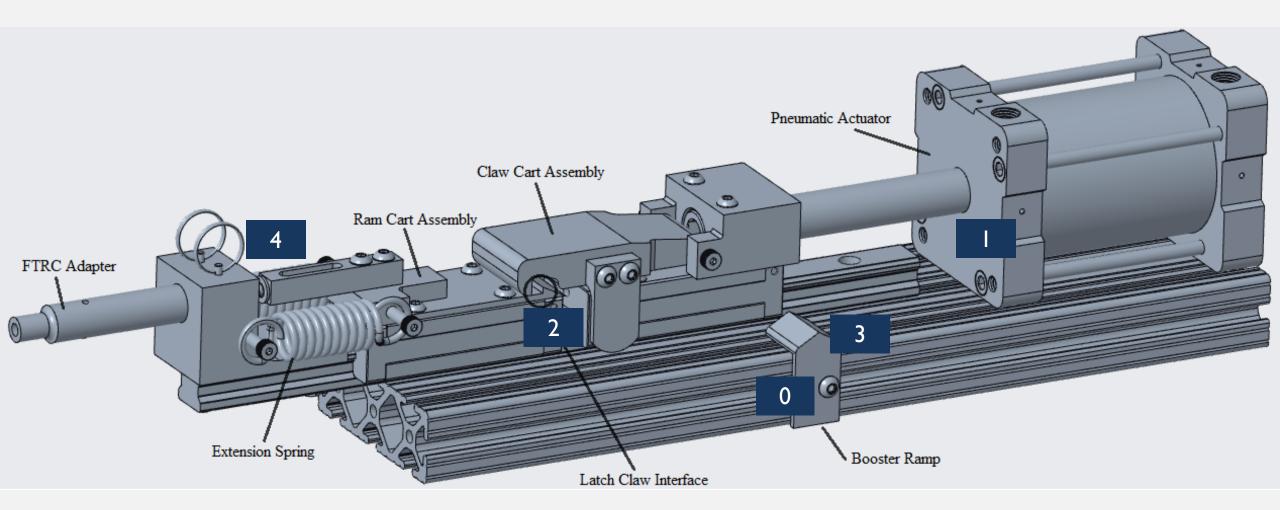


RamDent Device



# Trigger Method : RamDent

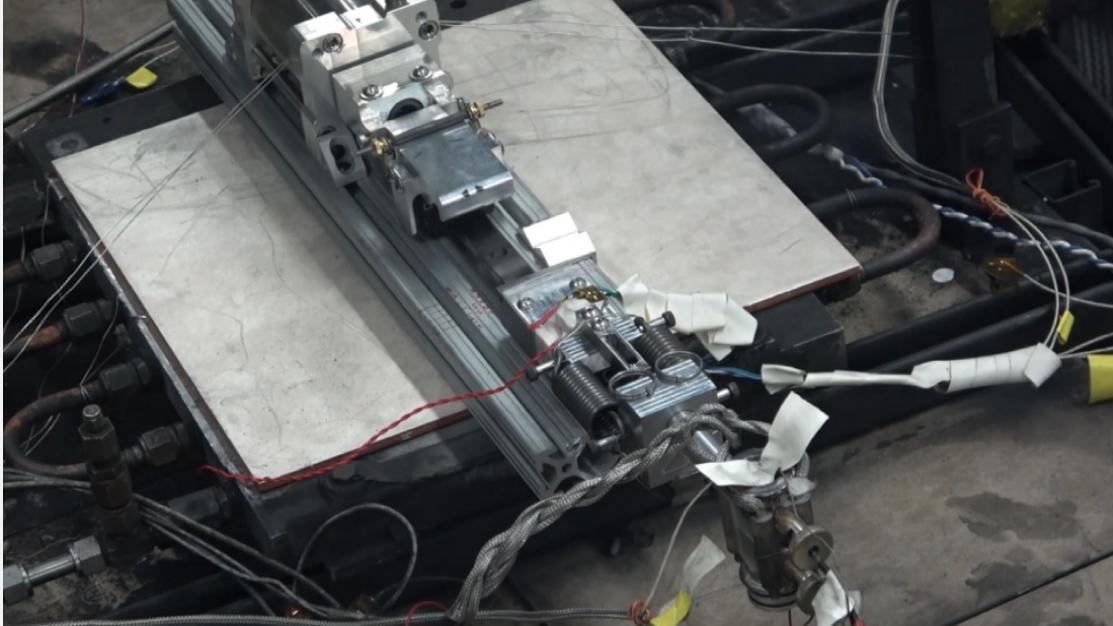






# Mechanism Phase 1

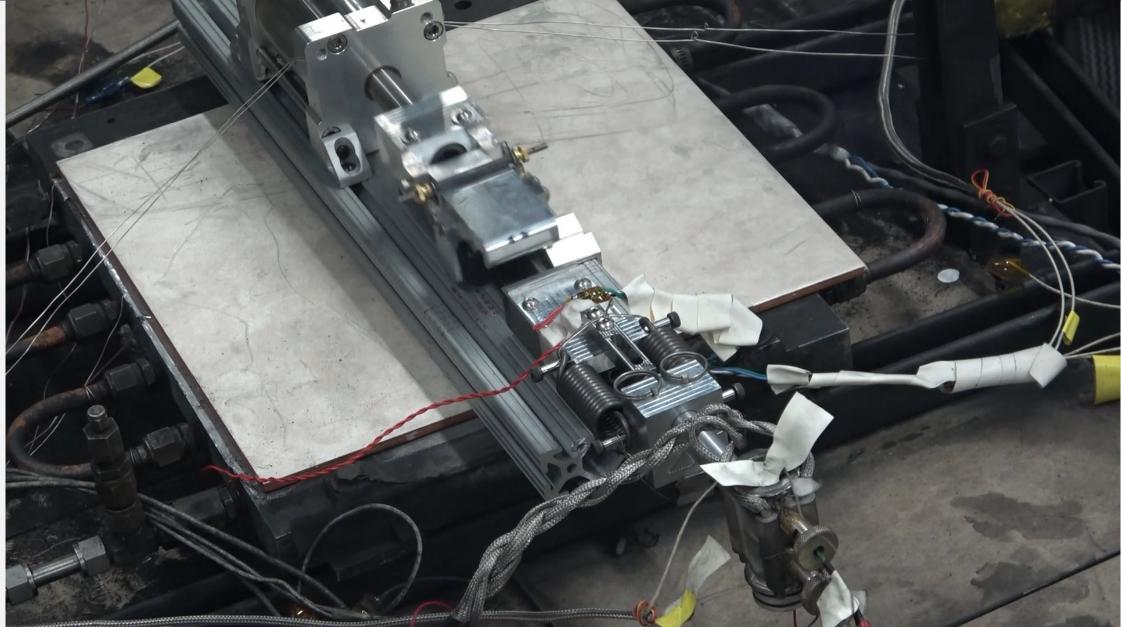






# Mechanism Phase 2

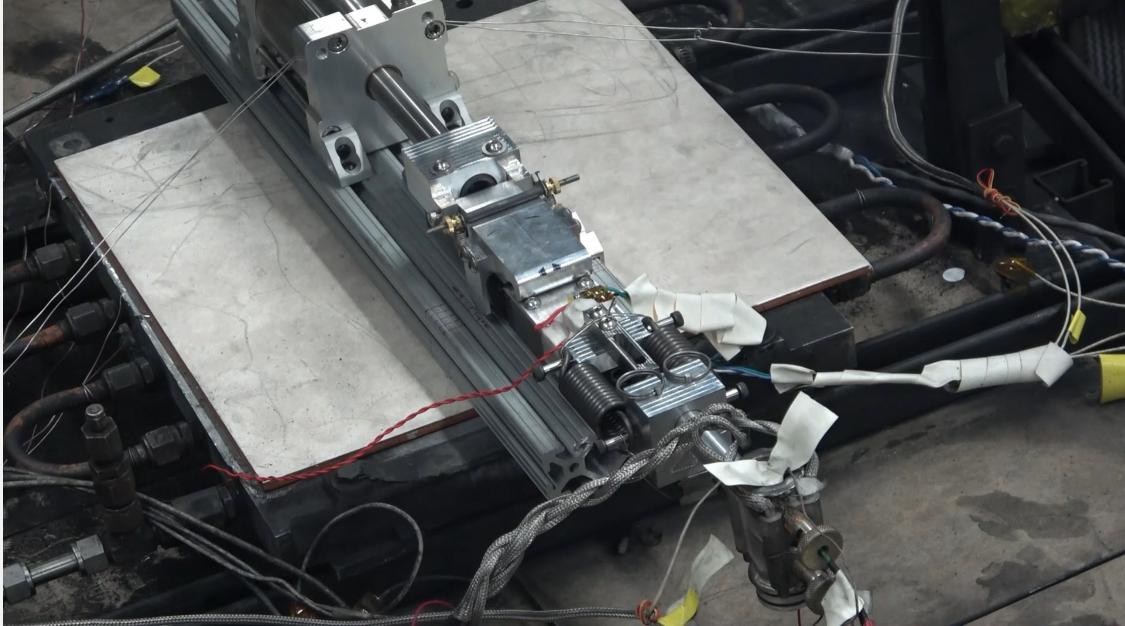






# Mechanism Phase 3







### Trigger Method: RamDent



### Benefits

- Creates a point defect in the cell
- Allows for fine-tuning of can wall deformation to suit different cell manufacturers and can wall thicknesses
- Able to mechanically and thermally decouple the testing device from the battery cell
- Can quantify minimum can wall deformation to create internal short circuit

#### **Drawbacks**

 Requires an additional test series to fine-tune the precise impact needed for specific cell types



# Trigger Mechanism Comparison



	Heater	Nail	ISCD	RamDent
		Penetration		
Time Effective		<b>~</b>		?
Non-Intrusive	<b>~</b>			<b>~</b>
Reliable			<b>✓</b>	?
Cost Effective	<b>✓</b>	<b>✓</b>		<b>✓</b>
Minimal Energy				
Input		<b>~</b>	<b>~</b>	~
Signal-Noise			./	
Ratio			•	•
Represents a				
Defect Induced				<b>✓</b>
Failure				



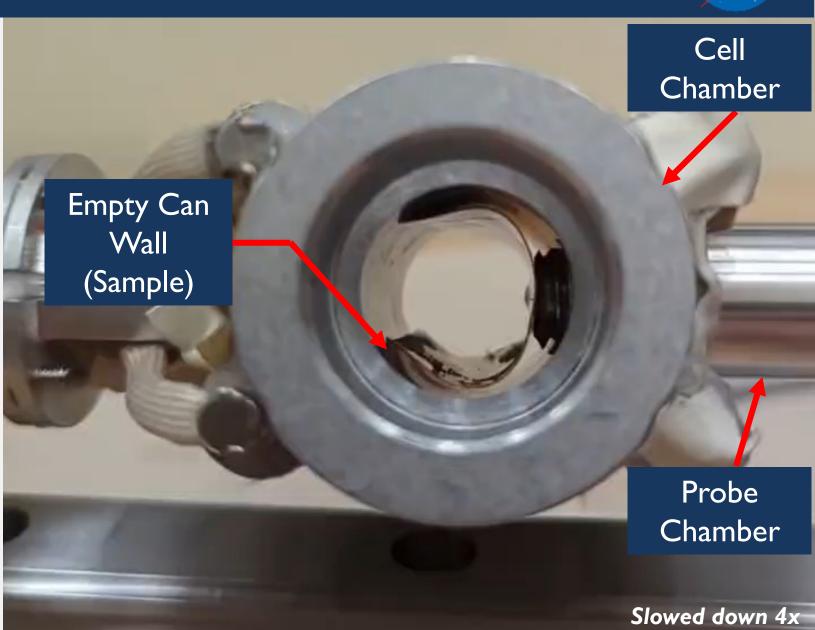
### Probe Test



### Test Set Up

- Fractional Thermal Runaway Calorimeter (FTRC) cell chamber for 18650 cell formats
- Empty steel can wall
- Probe chamber
- Probe exiting due to ram impact

 Employed a dome-shaped probe to create a precise type of deformation in cell can wall





## Experimental Design



 Selected two distinct 18650 cell types: LG M36 and Panasonic NCR18650A

	LG M36	Panasonic NCR-A
Can Wall Thickness	250 μm	125 μm
Capacity	3.4 Ah	3.I Ah
Anode	Graphite + Si Doping	Graphite
Cathode	Nickel Manganese Cobalt (NMC)	Nickel Cobalt Aluminum (NCA)



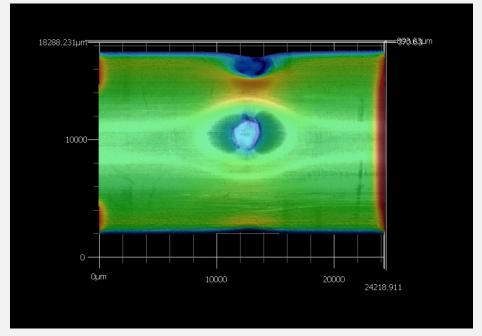
### Reliability Test: Dent Depth



- Extent to which the can wall is indented due to the applied force, measured in micrometers (μm)
- Utilized a 3-D optical profilometer to measure dent depths from discrete force impact intervals (0-100% force output)
- Investigating the dent depths generated to pinpoint the specific range on the force spectrum



LG M36 Initial Dent Test

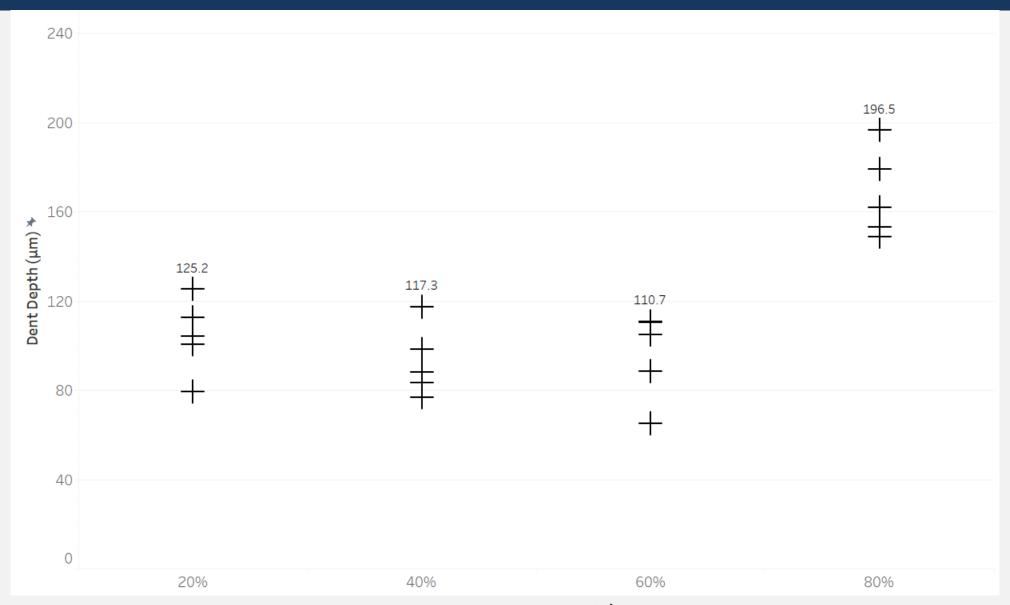


**Profilometer Measurement** 



## LG M36 Dent Test





Force Output (± 2.5%)



## Panasonic NCR-A Dent Test





Force Output (± 2.5%)



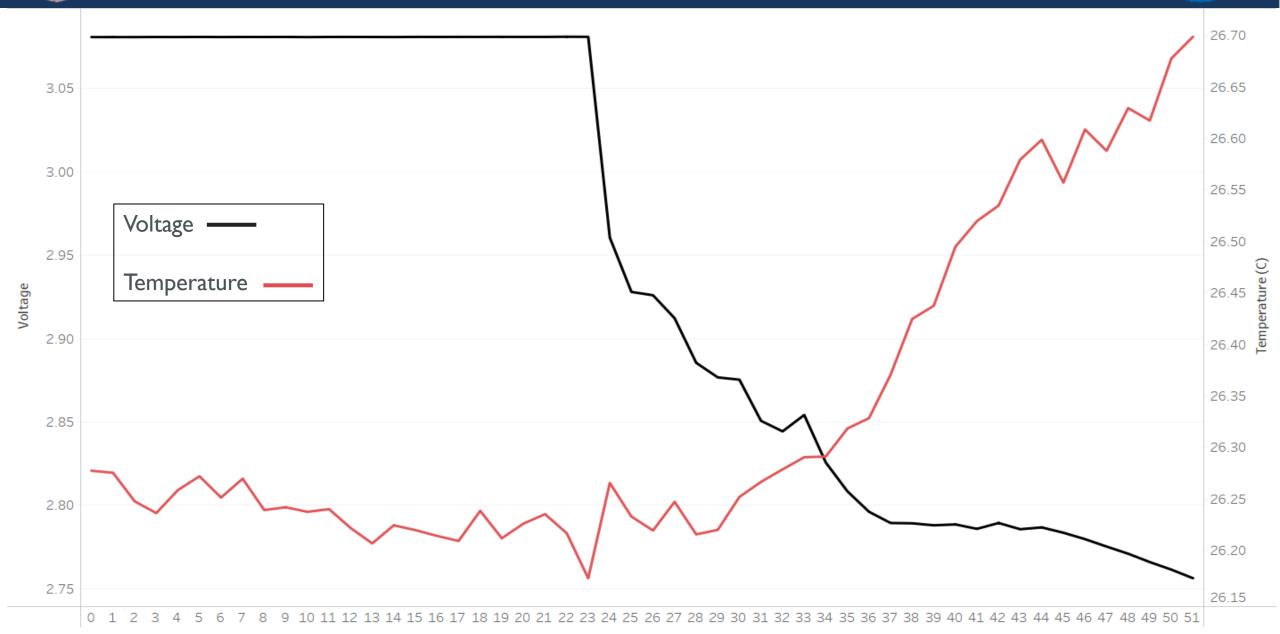
## Experimental Design

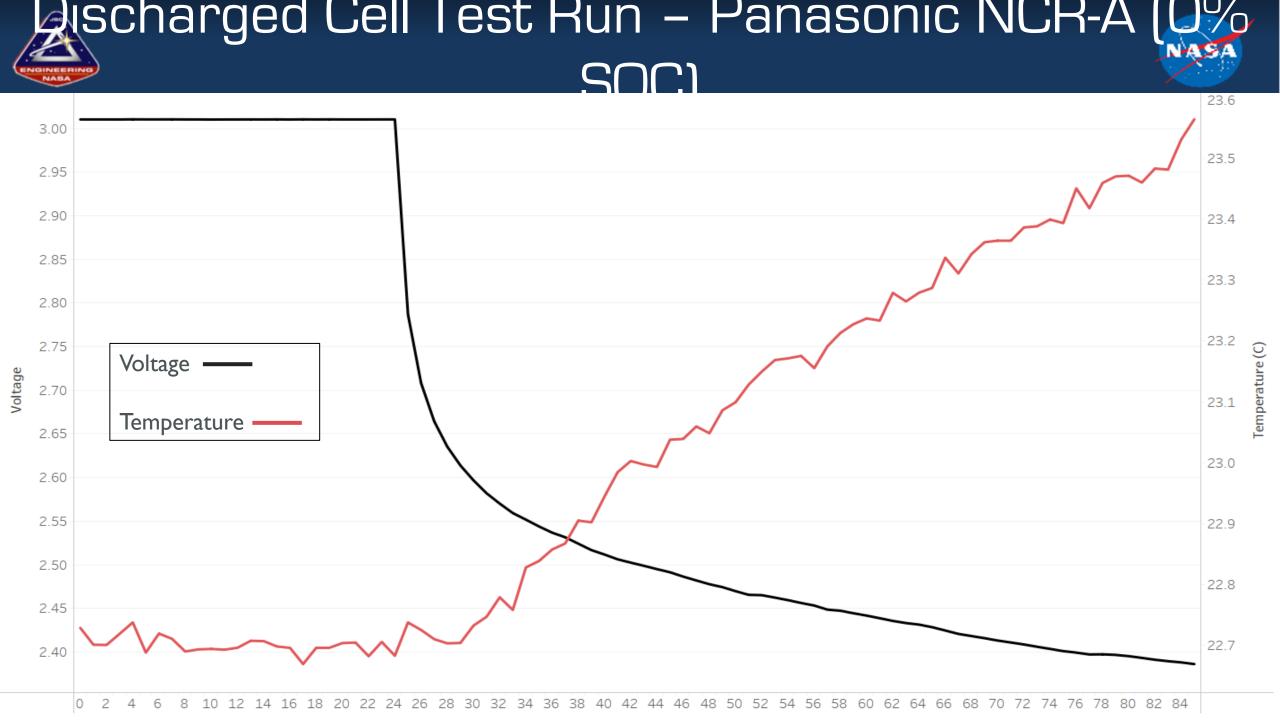


- Split the test series into two categories:
  - Discharged Cell Testing (0% state of charge)
  - Live Cell Testing (100% state of charge)
- Discharged Cell Testing Success defined by a specified voltage decrease within 5 seconds post-impact
- Live Cell Testing Success determined by the initiation of an internal short circuit within the cell without can wall perforation

After successfully initiating thermal runaway or an internal short circuit, focus on refining the force output for repeatability

# Discharged Cell Test Run - LG M36 (0% SOG)





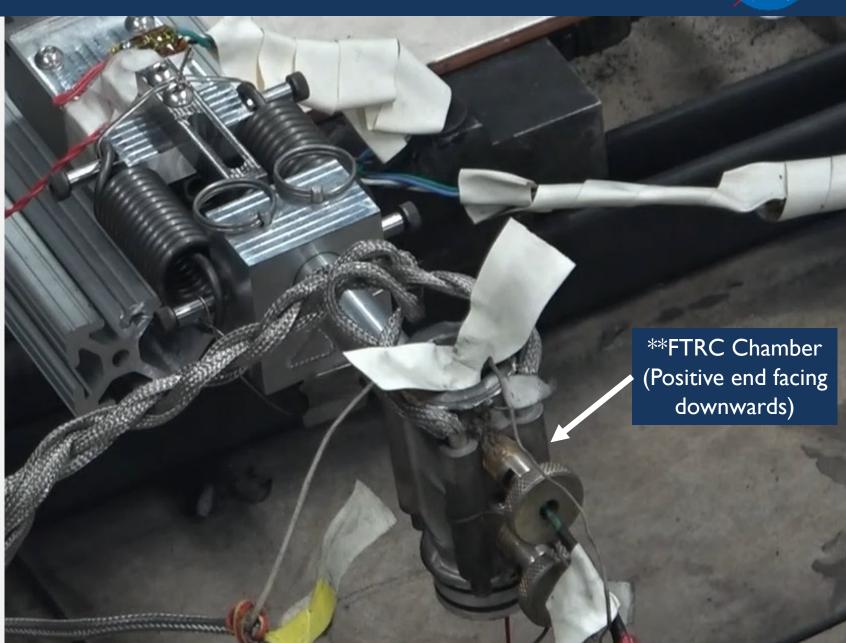


## Successful TR Initiation



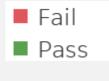
#### **Run Parameters**

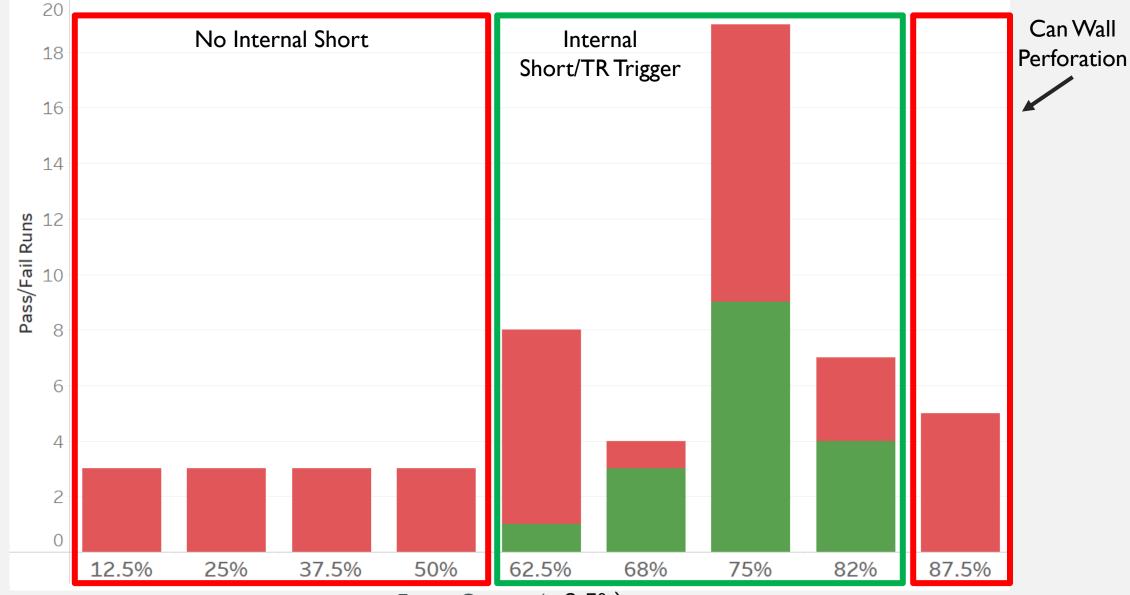
- LG M36 Cell
- 100% State of Charge
- 75% Force Output



# Preliminary Findings: LG M36 100% SUC Cell





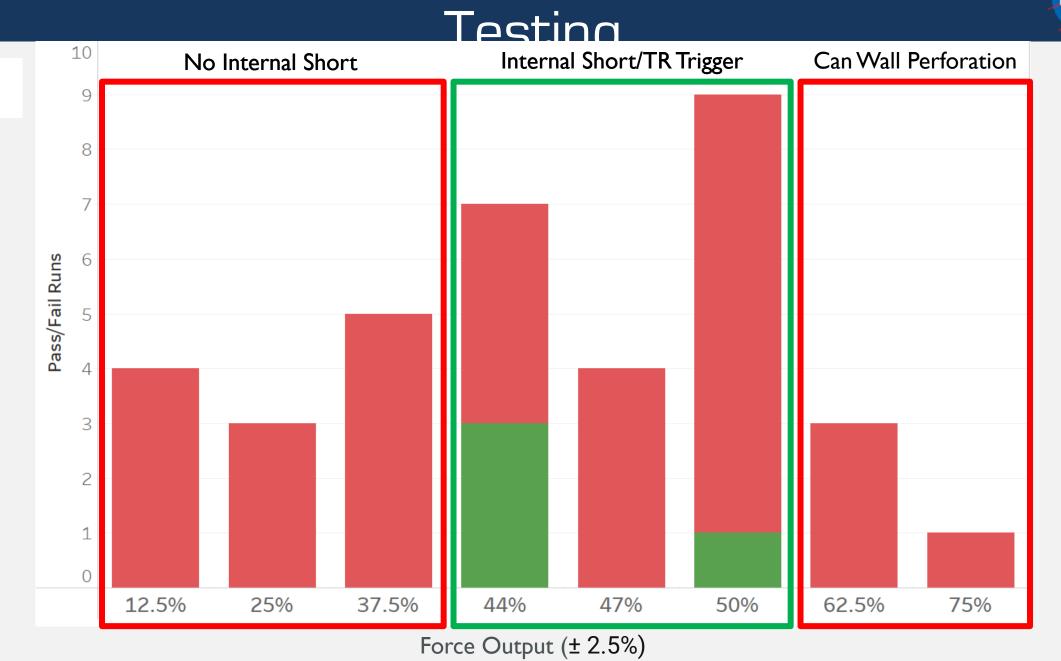


Force Output (± 2.5%)

# Preliminary Findings: Panasonic NCR-A Live Cell

Fail

Pass



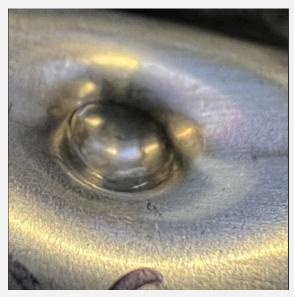


### Limitations of the Method



Due to time required to dial in the following parameters:

- Consistent force output (spring extension)
- Nail tip shape
- Nail tip ductility



LG M36 Test Cell Dent Shape (75% Force Output)

#### LG M36 Discharged Cells



20 % Force Output



40 % Force Output



60 % Force Output



80 % Force Output



### Conclusion



- Preliminary results show it is possible to induce internal shorts without can wall perforation and trigger a thermal runaway response
  - Accomplished with two cell designs with different can wall thicknesses
- Continuing further exploration of this trigger mechanism to improve consistency and worthy of integration into FTRC



### Future Work



- Accurately measuring kinetic energy
- Expand Test Series to Additional Cell Types and Sizes
- Integrate into FTRC testing
- Compact Redesign (Beam Time Compatible)
- Incremental SOC Reliability
   Study







### Acknowledgements

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